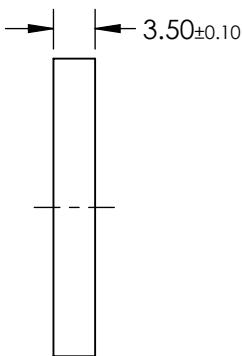
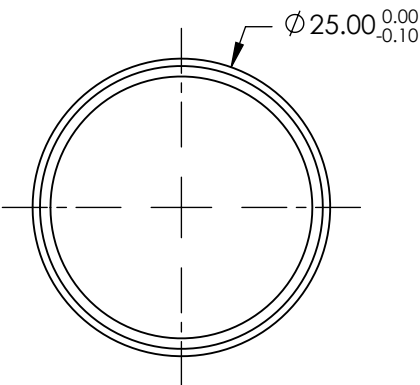
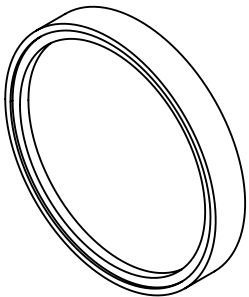


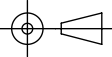
**FOR INFORMATION ONLY:
DO NOT MANUFACTURE
PARTS TO THIS DRAWING**



SUBSTRATE	Fused Silica
ANGLE OF INCIDENCE	0 ±2
BANDWIDTH (nm)	>900
CENTER WAVELENGTH CWL (nm)	785
OPTICAL DENSITY OD	≥6.0
SHAPE	PLANO
SURFACE QUALITY	60-40
TRANSMISSION (%)	93
EDGE STEEPNESS (nm)	3.9
TRANSITION WIDTH (nm)	<7.8
CLEAR APERTURE (%)	>80
DURABILITY	Environmental: MIL-STD-810F, Physical: MIL-C-48497A
RoHS	COMPLIANT

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE
DIMENSIONS ARE FOR REFERENCE ONLY

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THIRD ANGLE PROJECTION 		TITLE	25mm Dia., 785nm Laser Line Longpass Filter	
ALL DIMS IN	mm	DWG NO	47508	SHEET 1 OF 1